



GALAXY



## FEATURES

Integration with CIMS  
AOI systems

Combines final  
inspection with regular  
inspection

Supports both sampling  
and 100% inspection

Dedicated user  
interface for final  
inspection

Easy and intuitive setup

## OPTICAL FINAL INSPECTION

Fi (Final Inspection) option allows inspecting of finished boards with CIMS AOI. It is supplied as an add-on option suitable for all CIMS Phoenix & Galaxy AOI models extending their capabilities to final inspection.

Fi can reliably detect common defects on gold, copper and solder mask. The setup is easy and intuitive: operator chooses proper solder and silk layers, then the software takes care of combining them and generating high resolution reference which will be compared to the scanned image.

Systems equipped with Fi option feature a dedicated final inspection interface for parameters setup.

Fi option adds a new level of versatility to all AOI systems enhancing their inspection capabilities to more applications and PCB manufacturing process stages.

Interested in an online demo, or demo at our office? Please contact us!



## MORE INFORMATION

ADEON TECHNOLOGIES

Weidehek 26

NL-4824 AS Breda

0031 (0) 76 541 00 08

E-mail: [info@adeon.nl](mailto:info@adeon.nl)

[www.adeon.nl](http://www.adeon.nl)